520.41003X00

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s):

KIMURA et al.

Serial No.:

Not yet assigned

Filed:

On even date

For:

POLYCRYSTALLINE SEMICONDUCTOR THIN FILM SUBSTRATE, MANUFACTURING METHOD OF THE SAME, SEMICONDUCTOR DEVICE AND ELECTRONIC

DEVICE

## UNDER 37 CFR 1.97 & 1.98

Assistant Commissioner for Patents Washington, D.C. 20231

December 28, 2001

Sir:

In the matter of the above-identified application, applicants are submitting herewith a copy of a communication from a foreign patent office in a counterpart foreign application and copies of the documents listed in the attached form equivalent to Form PTO-1449 for the Examiner's consideration.

This information disclosure statement is being submitted with the new application.

To the extent the documents listed on the attached form equivalent to Form PTO-1449 are not in the English language, the requirement of 37 CFR 1.98(a)(3) for a concise explanation of the relevance is satisfied by the discussion of these documents in the specification, for example, on page 2.

It is respectfully requested that this information disclosure statement be considered by the Examiner.

Please charge any shortage in the fees due in connection with the filing of this paper, including extension of time fees, to the deposit account of Antonelli, Terry, Stout & Kraus Deposit Account No. 01-2135 (520.41003X00) please credit any excess fees to such deposit account.

Respectfully submitted,

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10/019407 JP42 Rec'd PCT/PTO 28 DEC 2001

Sheet 1 of 1

Form PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DKT. NO. 520.41003X00	SERIAL NO.  Not yet assigned		
INFORMAT	ION DISCLOSURE STATEMENT	APPLICANT			
BY APPLICANT		KIMURA et al.			
a.		FILING DATE	GROUP		
(Use several sheets if necessary)		Dec. 28, 2001			

## **U.S. PATENT DOCUMENTS**

Examiner Initial	Document Number	Date N	Name	Class	Subclass	Filing Date	
AA	·						
AB							
AC							
AD							
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АН							
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AK							

## FOREIGN PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Country	Class	Subclass	Translation /Abstract	
						1	Yes	No
	AL						<del></del>	
	AM					<del>                                     </del>		
	AN		<del>                                     </del>			+		
	AO					<del> </del>		

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	AP	SID 96 Digest, pp. 17-20			
	AQ	IEEE Transactions on Electron Devices, Vol. 43, No. 9, September 1996, pp. 1454-1458			
	AR	Appl. Phys. Lett. 63(14), 4 October 1993, pp. 1969-1971			
		Proceedings of the Institute of Electronics, Information and Communication Engineers C-II Vol. J76-C-II, 1993, pp. 241-248			
Examine	er	Date Considered			